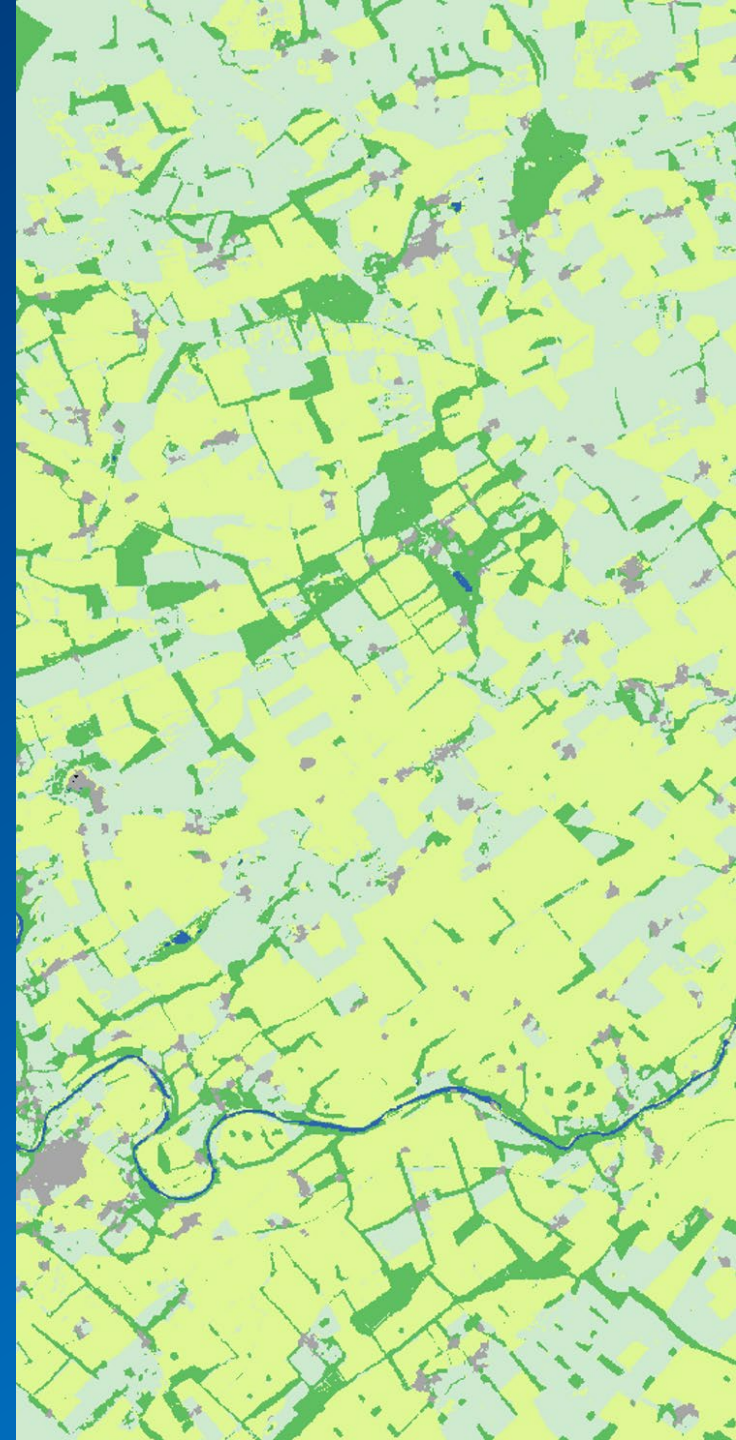


Pixel-level validation of land cover maps - an outlook from the perspective of metrology

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Quality assessment of land cover (LC) maps

- Quality assessment of LC maps is coordinated by CEOS WGCV LPV LC focus group
- In September 2025, the LC focus group released a new Good Practice Validation Protocol
- This protocol is largely focused on LC map's quality assessment based on confusion matrices



Main limitation: confusion matrix provides no information on per-pixel quality of LC maps

Confusion matrix

		Reference dataset				
		A	B	C	D	Σ
Land cover map	LC class A	p_{AA}	p_{AB}	p_{AC}	p_{AD}	p_{A+}
	B	p_{BA}	p_{BB}	p_{BC}	p_{BD}	p_{B+}
	C	p_{CA}	p_{CB}	p_{CC}	p_{CD}	p_{C+}
	D	p_{DA}	p_{DB}	p_{DC}	p_{DD}	p_{D+}
	Σ	p_{+A}	p_{+B}	p_{+C}	p_{+D}	1

$K = \#$ of classes

$$\text{Overall accuracy (OA)} = \sum_{k=1}^K p_{kk} \times 100$$

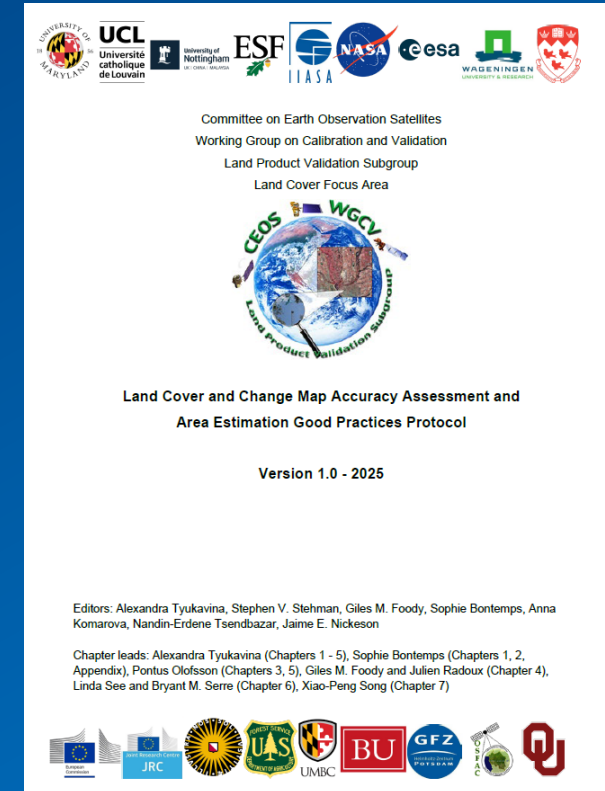
$$\text{User's accuracy (UA)} = \frac{p_{kk}}{p_{k+}} \times 100$$

$$\text{Commission errors} = 100 - \text{UA}$$

$$\text{Producer's accuracy (PA)} = \frac{p_{kk}}{p_{+k}} \times 100$$

$$\text{Omission errors} = 100 - \text{PA}$$

- Indicators of per-pixel quality (specifically, metrologically rigorous per-pixel uncertainties) are needed for propagation to downstream applications of LC maps

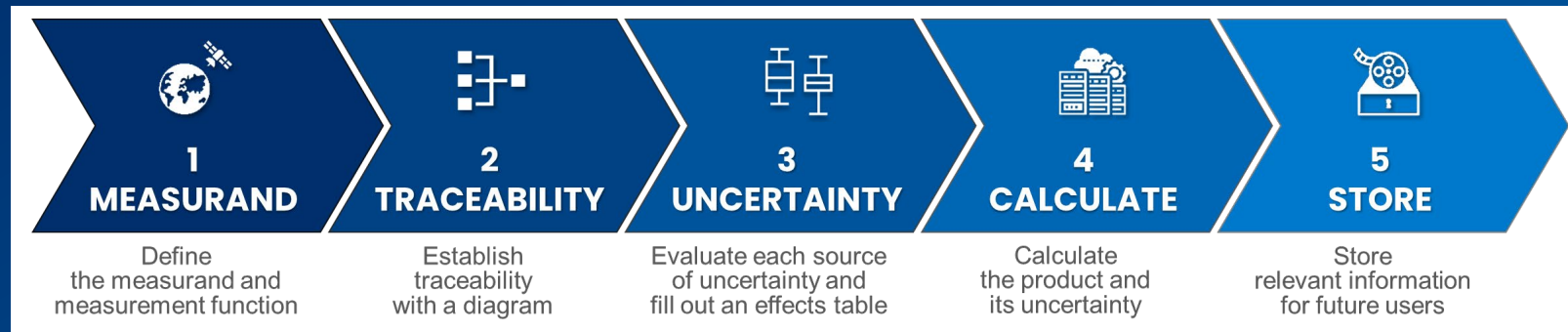


https://lpvs.gsfc.nasa.gov/PDF/CEOS_WGCV_LPV_Land_Cover_protocol_Sept2025_V1.pdf

Metrologically rigorous uncertainties and their validation **NPL**

- For more typical EO products (i.e., quantitative products such as surface reflectance, land or sea surface temperature), the estimation of per-pixel metrologically rigorous uncertainties and their validation can be performed by following the QA4EO guidelines

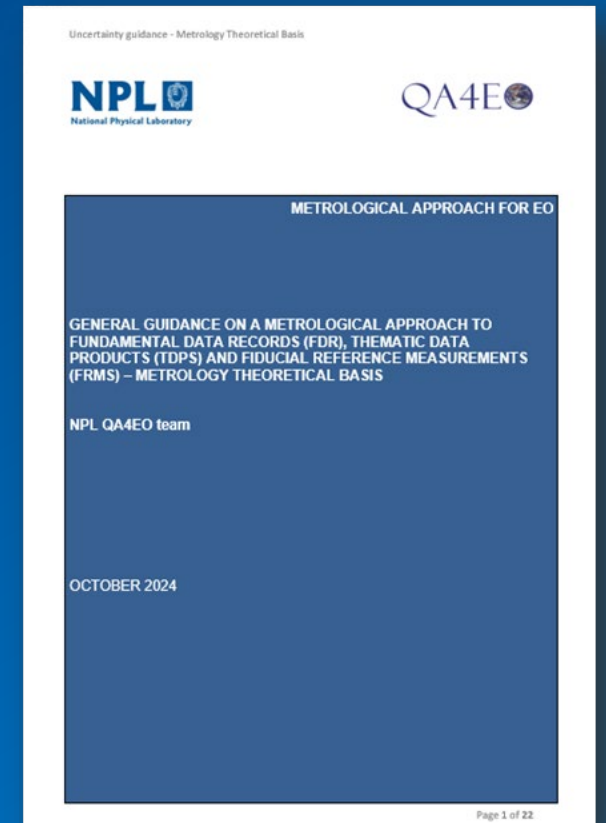
Uncertainty estimation



Validation of uncertainties

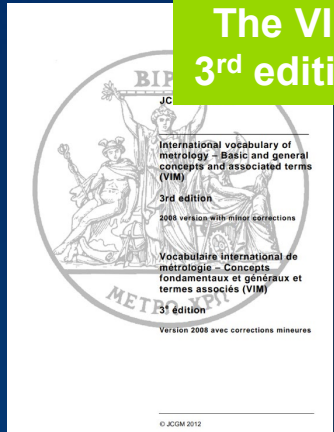
$$E_N = \frac{|\rho_1 - \rho_2|}{k \sqrt{u_1^2 + u_2^2 + u_{\text{comp}}^2}}$$

Not directly applicable to categorical variables



Categorical variables in metrology

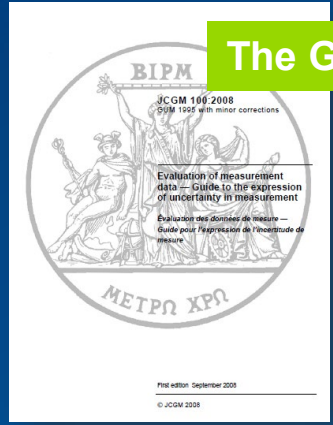
- QA4EO guidelines represent the adaptations of the authoritative metrological documents for EO domain



The VIM 3rd edition

- is focused on quantities
- provides a definition of categorical variables (i.e., nominal properties)
- clarifies that the term measurement (and therefore measurement uncertainty) does not apply to categorical variables
- does not provide an alternative uncertainty term that would be applicable to categorical variables

https://www.bipm.org/documents/20126/2071204/JCGM_200_2012.pdf



The GUM

- is focused on quantities
- only exception - GUM-4 on Conformity assessment (a special case of categorical variables)

<https://doi.org/10.59161/JCGM100-2008E>

NB the interest towards categorical variables has been growing in the metrology community in recent years:

- the 4th VIM is expected to have an entire chapter on categorical variables
- uncertainty and other metrological concepts have been discussed in several international standards and metrology-related publications

Eurachem/CITAC
Assessment of measurement uncertainty in analytical chemistry: performance and qualitative chemical

IUPAC Recommendations
Vocabulary on nominal property, examination and related concepts for clinical laboratory sciences (IFCC-IUPAC Recommendations)

NIST Technical Note 1900
Simple Guide for Evaluating and Expressing the Uncertainty of NIST Measurement Results

International Standard
ISO 33406:2024

ISO 33406
First edition 2024-05

Measurement
Foundations of uncertainty in evaluation of nominal properties

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Keywords
Nominal property
Uncertainty

ABSTRACT
Measurement uncertainty is a key component of metrology but, as it is defined, it does not apply to nominal properties. The possibility to define, evaluate, and express the uncertainty in the evaluation of nominal properties is then a critical prerequisite for a harmonized treatment of nominal property metrology. The assumption at the basis of this paper is that examination uncertainty can be used in analogy with and as a generalization of measurement uncertainty. In this sense a foundational work is introduced, grounded on a generic concept of evaluation uncertainty that applies equally to quantitative and non-quantitative evaluation. Based on this, a concept of examination uncertainty is presented and some examples of mathematical functions of examination uncertainty are proposed.

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Categorical variables in EO

Due to the lack of metrological guidance from the VIM and the GUM (and the QA4EO) for categorical EO products, we need to start with answering the basic questions:

Q1: What are uncertainties for categorical variables?

Q2: To what extent are the principles of uncertainty estimation and validation developed for quantities transferable to categorical variables?

Categorical variables in EO

- **Q1:** What are uncertainties for categorical variables?
 - Uncertainty can be fully expressed by Probability Mass Function (PMF)
- **Q2:** To what extent are the principles of **uncertainty estimation** and validation developed for quantities transferable to categorical variables?
 - Similarly to quantities, the combined uncertainty for categorical variables can be obtained by propagating all contributing sources of uncertainty

submitted to Metrologia in March 2025

A metrological framework for uncertainty evaluation in machine learning classification models

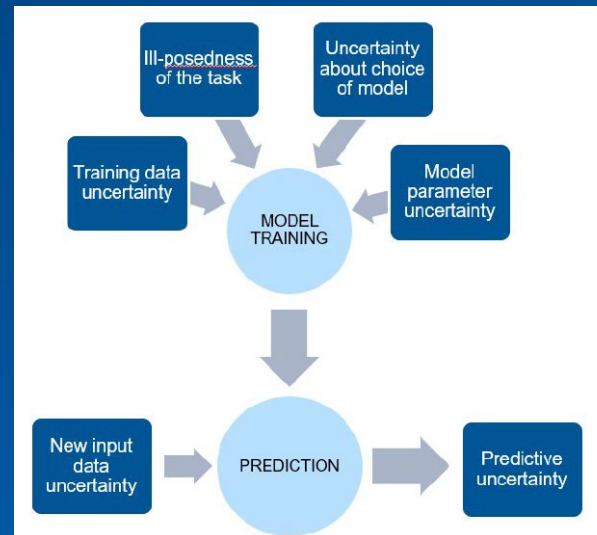
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³School of Geography, Geology & The Environment, University of Leicester, Leicester, UK

<https://arxiv.org/abs/2504.03359>



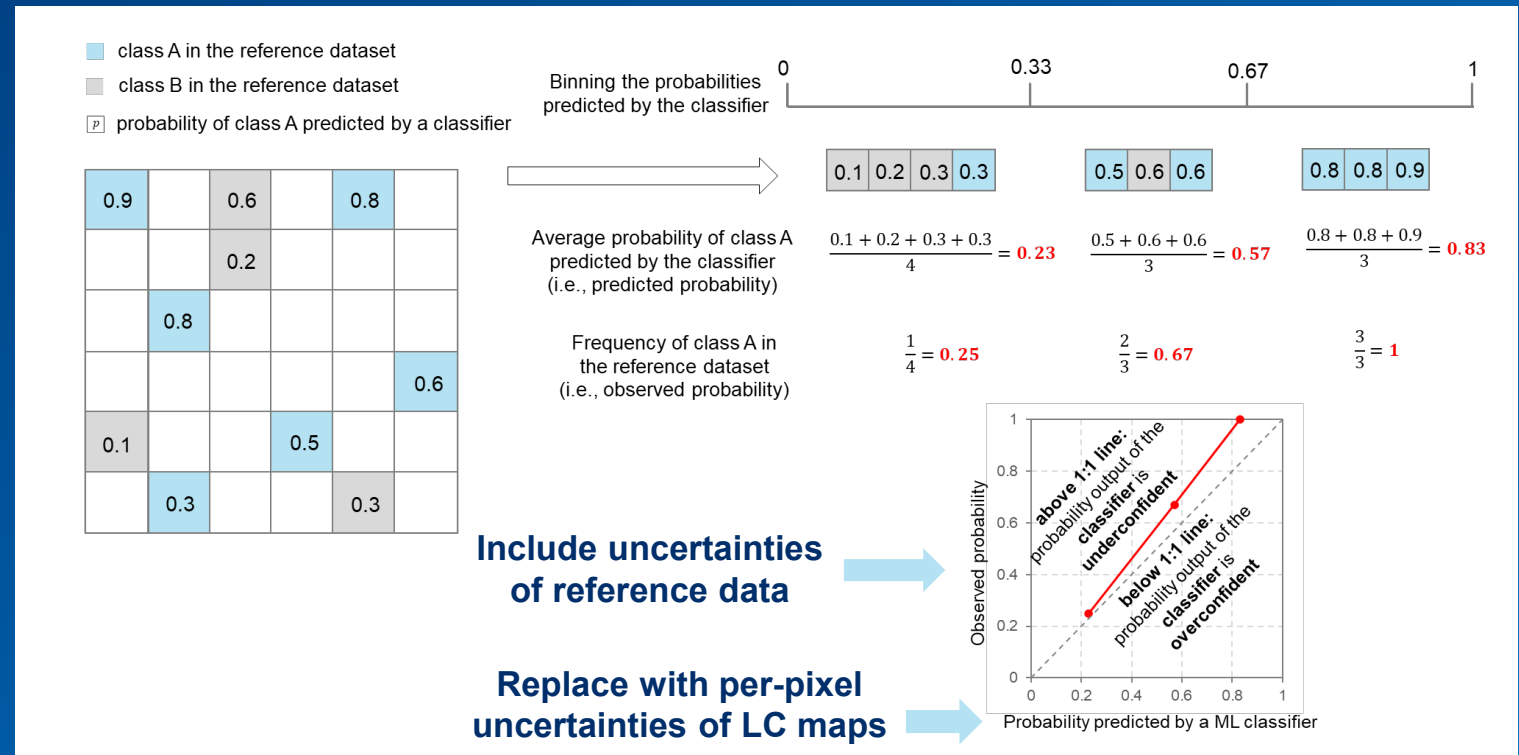
Categorical variables in EO

- **Q2:** To what extent are the principles of uncertainty estimation and **validation** developed for quantities transferable to categorical variables?

Quantitative variables →
Equivalence ratio

$$E_N = \frac{|\rho_1 - \rho_2|}{k \sqrt{u_1^2 + u_2^2 + u_{comp}^2}}$$

Categorical variables →
Adaptation of “classifier calibration” method



ESA Met4EO (Metrology for Earth Observation) project

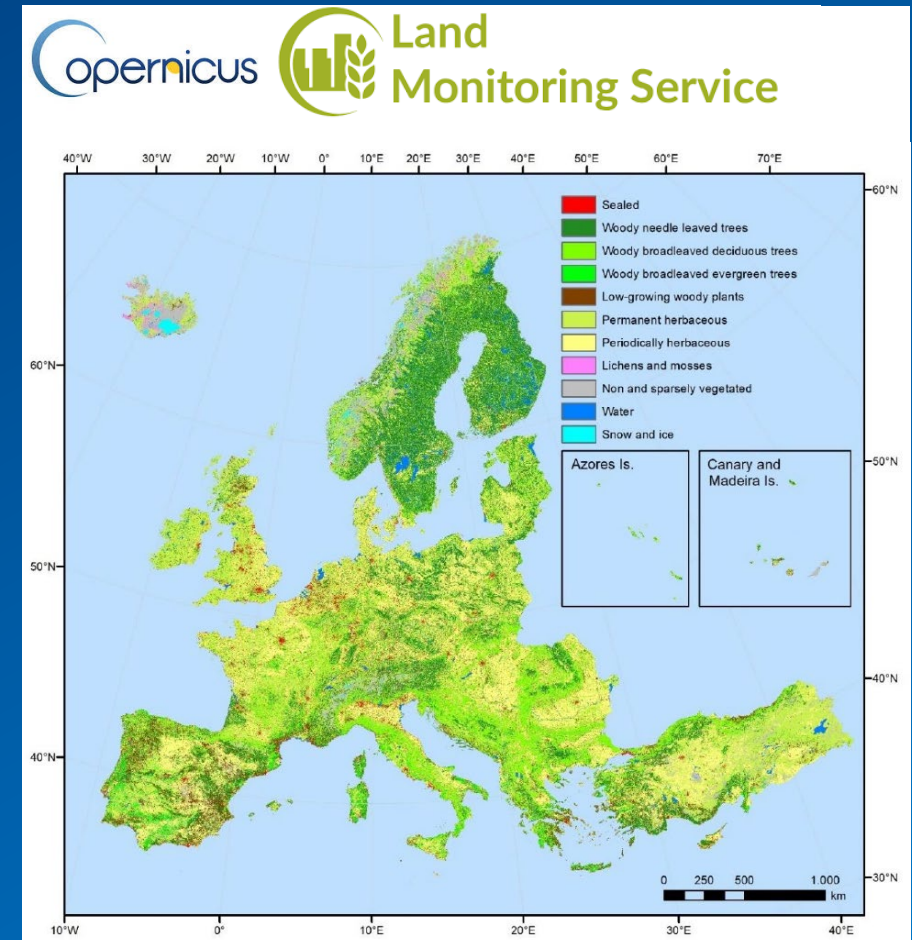


- A new **ESA project delivered by NPL**, with the objective of developing innovative concepts for assessing the quality of various EO products following the principles of metrology. Including:
 - WP1: AI for Cal/Val
 - WP2: Metrology Tools, Training and Support
 - WP3: Metrology for Land Cover Classification**
 - WP4: CEOS-PVP
 - WP5: Uncertainty Analysis for Altimetry
- The **three objectives of WP3** is
 - to implement a prototype framework for metrologically rigorous estimation of per-pixel uncertainties of LC maps
 - to implement a prototype framework for the validation of these uncertainties
 - to define the pathway for applying the FRM concept to LC maps

ESA Met4EO project

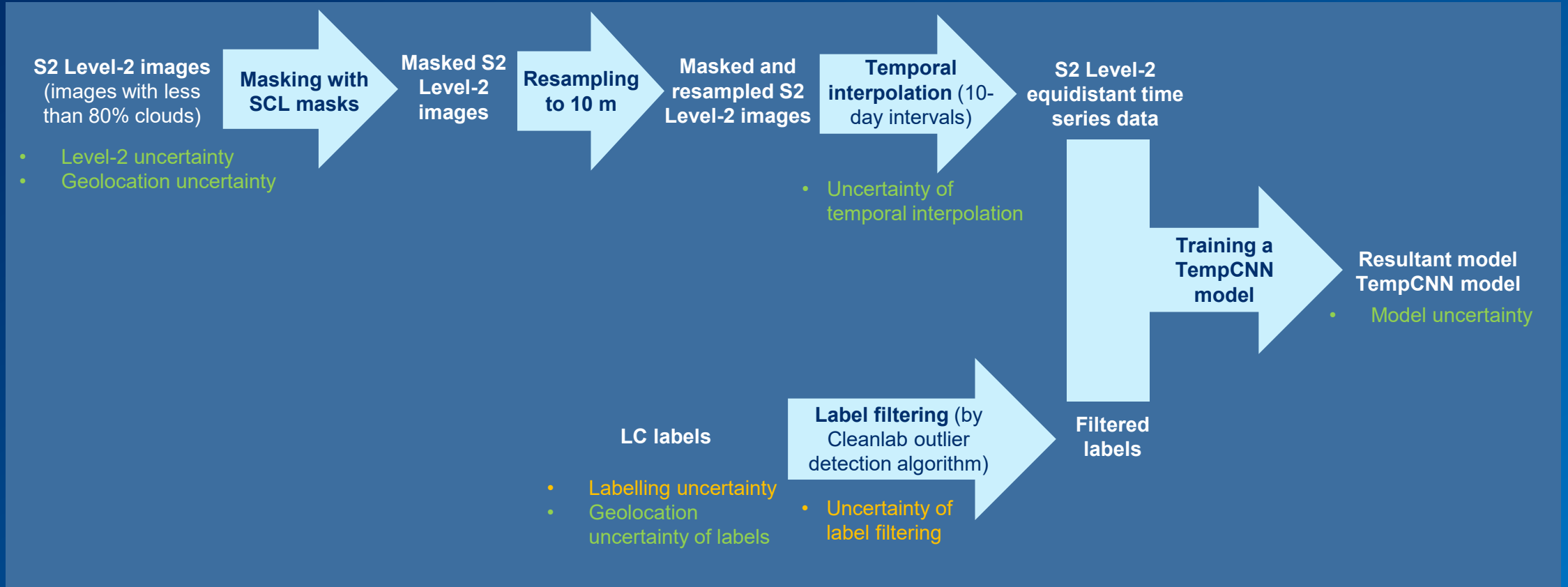
LC classification

- We are using the processing chain of CLMS CLCplus Backbone LC product as a foundation (with some modifications)
 - developed by Copernicus Land Monitoring Service (CLMS)
 - high resolution (10 m) product of European land cover
 - is produced
 - based on a time series of Sentinel-2
 - 8 bands and 4 spectral indices
 - B1, B3, B4, B5, B8, B9, B11, B12
 - NDVI, NDWI, NDMI, NBR
 - by Temporal Convolutional Neural Network (TempCNN) classifier
 - training data: LUCAS, existing CLMS LC products, photo-interpretation of VHR, etc.
 - 11 basic LC classes



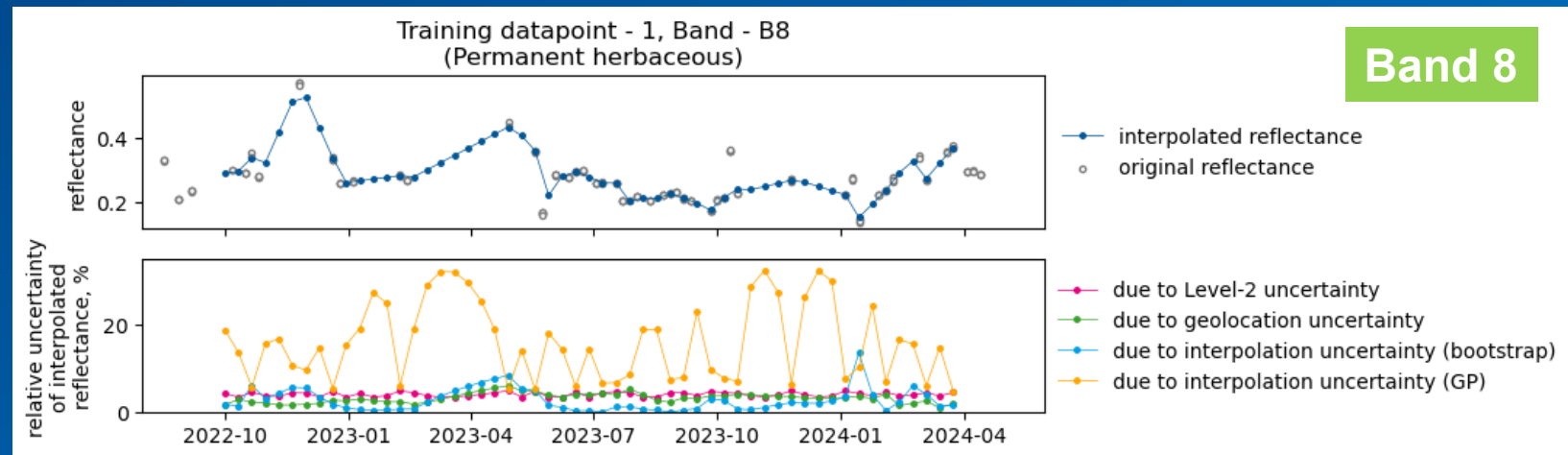
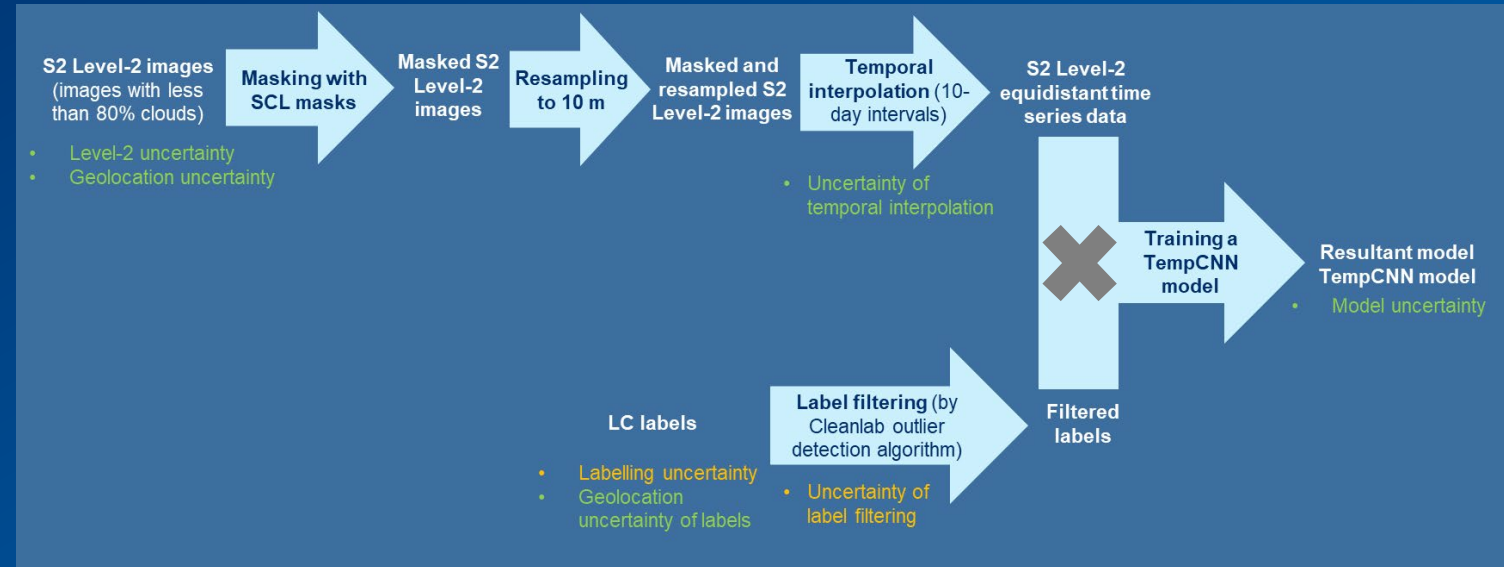
ESA Met4EO project

CLCplus Backbone LC product (training stage)



Uncertainty propagation framework

- Sentinel-2 Level-2 uncertainty
 - based on SIAC atmospheric correction
- Geolocation uncertainty
 - Sentinel-2 positional accuracy
 - positional accuracy of a typical GPS sensor
- Temporal interpolation uncertainty
 - Gaussian Processes (being refined)
 - Bootstrap resampling (being refined)



Other efforts on bringing metrology to LC mapping

- Noteworthy efforts in the same direction – estimating metrologically rigorous per-pixel uncertainties of LC maps – are currently being made by the ESA CCI MRLC team



The screenshot shows the front page of a journal article. At the top left is the 'land cover cci' logo with a globe icon. Below it, the journal title 'Remote Sensing of Environment' is displayed, along with the Elsevier logo and the journal homepage URL 'www.elsevier.com/locate/rse'. The article title is 'Monte Carlo uncertainty analysis from top-of-atmosphere reflectance to plant functional type distributions'. The authors listed are R. Quast, G. Kirches, C. Brockmann, M. Böttcher, R. Shevchuk, C. Lamarche, P. Defourny, C.M.J. Albergel, and O. Arino. Below the authors are their affiliations: Brockmann Consult GmbH (Germany), ELIR (Belgium), ESA-ESCAT (United Kingdom), and ESA-ESRIN (Italy). The page is divided into 'ARTICLE INFO' and 'ABSTRACT' sections. The 'ARTICLE INFO' section includes the editor's name (Marie Weiss), a dataset link, and a list of MSC codes. The 'ABSTRACT' section contains the beginning of the article's text, discussing the importance of metrology in climate data records and the application of Monte Carlo methodology to estimate uncertainties in land cover mapping.

Conclusions

- Land cover represents a categorical variable
- Uncertainty evaluation and validation of uncertainties for such variables are currently not covered by the GUM and the VIM (and consequently by the QA4EO)
- In this presentation, we showed the ongoing efforts dedicated to addressing this gap



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